

<b>Notice of References Cited</b>	Application/Control No. 10/659,609	Applicant(s)/Patent Under Reexamination BU ET AL.	
	Examiner Hien D. Vu	Art Unit 2833	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,470,242	11-1995	Cheng et al.	439/157
X	B	US-5,411,408	05-1995	DiViesti et al.	439/326
X	C	US-5,676,561	10-1997	Chiang, Mika	439/328
X	D	US-5,443,394	08-1995	Billman et al.	439/157
X	E	US-5,820,396	10-1998	Pan et al.	439/328
X	F	US-4,898,540	02-1990	Saito, Masaaki	439/153
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.